TEST REPORT

FCC LTE B13 Test for SM-S721B/DS
Certification

APPLICANT
SAMSUNG Electronics Co., Ltd.

REPORT NO.
HCT-RF-2407-FC055

DATE OF ISSUE
July 24, 2024

Tested by
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TEST REPORT

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Additional Model
SM-S721B

Applicant	**SAMSUNG Electronics Co., Ltd.** 129, Samsung-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16677, Rep. of Korea
Product Name Model Name	Mobile Phone SM-S721B/DS
Date of Test	May 21, 2024 ~ July 23, 2024
FCC ID	A3LSMS721B
Location of Test	■ Permanent Testing Lab ☐ On Site Testing (Address: 74, Seoicheon-ro 578beon-gil, Majang-myeon, Icheon-si, Gyeonggi-do, 17383 Republic of Korea)
FCC Classification:	PCS Licensed Transmitter Held to Ear (PCE)
Test Standard Used	FCC Rule Part : § 27
Test Results	PASS

REVISION HISTORY

The revision history for this test report is shown in table.

Revision No.	Date of Issue	Description
0	July 24, 2024	Initial Release

Notice

Content
The measurements shown in this report were made in accordance with the procedures specified in CFR47 section § 2.947. I assume full responsibility for the accuracy and completeness of these measurements, and for the qualifications of all persons taking them. HCT CO., LTD. Certifies that no party to this application has subject to a denial of Federal benefits that includes FCC benefits pursuant to section 5301 of the Anti-Drug Abuse Act of 1998,21 U.S. C.853(a)
The results shown in this test report only apply to the sample(s), as received, provided by the applicant, unless otherwise stated. The test results have only been applied with the test methods required by the standard(s). The laboratory is not accredited for the test results marked *. Information provided by the applicant is marked **. Test results provided by external providers are marked ***.
When confirmation of authenticity of this test report is required, please contact www.hct.co.kr
The test results in this test report are not associated with the ((KS Q) ISO/IEC 17025) accreditation by KOLAS (Korea Laboratory Accreditation Scheme) / A2LA (American Association for Laboratory Accreditation) that are under the ILAC (International Laboratory Accreditation Cooperation) Mutual Recognition Agreement (MRA).

CONTENTS

MEASUREMENT REPORT

1. GENERAL INFORMATION

Applicant Name:	SAMSUNG Electronics Co., Ltd.
Address:	129, Samsung-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16677, Rep. of Korea
FCC ID:	A3LSMS721B
Application Type:	Certification
FCC Classification:	PCS Licensed Transmitter Held to Ear (PCE)
FCC Rule Part(s):	§ 27
EUT Type:	Mobile phone
Model(s):	SM-S721B/DS
Additional Model(s)	SM-S721B
Tx Frequency:	779.5 MHz –784.5 MHz (LTE – Band 13 (5 MHz)) 782 MHz (LTE – Band 13 (10 MHz))
Date(s) of Tests:	May 21, 2024 ~ July 23, 2024
Serial number:	Radiated : R3CX40LGCGM Conducted : R3CX503EC1Z

1.1. MAXIMUM OUTPUT POWER

Mode (MHz)	Tx Frequency (MHz)	Emission Designator	Modulation	ERP	
				Max. Power (W)	Max. Power (dBm)
LTE – Band13 (5)	779.5 –784.5	4M50G7D	QPSK	0.111	20.44
		4M53W7D	16QAM	0.073	18.62
		4M51W7D	64QAM	0.059	17.70
		4M51W7D	256QAM	0.045	16.57
LTE – Band13 (10)	782.0	9M02G7D	QPSK	0.109	20.36
		9M01W7D	16QAM	0.071	18.50
		9M03W7D	64QAM	0.058	17.63
		9M00W7D	256QAM	0.045	16.52

2. INTRODUCTION

2.1. DESCRIPTION OF EUT

The EUT was a Mobile Phone with GSM/GPRS/EGPRS/UMTS and LTE, Sub 6.
It also supports IEEE 802.11 a/b/g/n/ac/ax (20/40/80/160 MHz), Bluetooth(ePA), BT LE(ePA), NFC, WPT, WIFI 6E.

2.2. MEASURING INSTRUMENT CALIBRATION

The measuring equipment, which was utilized in performing the tests documented herein, has been calibrated in accordance with the manufacturer's recommendations for utilizing calibration equipment, which is traceable to recognized national standards.

2.3. TEST FACILITY

The Fully-anechoic chamber and conducted measurement facility used to collect the radiated data are located at the **74, Seoicheon-ro 578beon-gil, Majang-myeon, Icheon-si, Gyeonggi-do, 17383, Rep. of KOREA.**

3. DESCRIPTION OF TESTS

3.1 TEST PROCEDURE

Test Description	Test Procedure Used
Occupied Bandwidth	- KDB 971168 D01 v03r01 – Section 4.3 - ANSI C63.26-2015 – Section 5.4.4
Band Edge	- KDB 971168 D01 v03r01 – Section 6.0 - ANSI C63.26-2015 – Section 5.7
Spurious and Harmonic Emissions at Antenna Terminal	- KDB 971168 D01 v03r01 – Section 6.0 - ANSI C63.26-2015 – Section 5.7
Conducted Output Power	- N/A (See SAR Report)
Frequency stability	- ANSI C63.26-2015 – Section 5.6
Effective Radiated Power/ Effective Isotropic Radiated Power	- KDB 971168 D01 v03r01 – Section 5.2 & 5.8 - ANSI/TIA-603-E-2016 – Section 2.2.17
Radiated Spurious and Harmonic Emissions	- KDB 971168 D01 v03r01 – Section 6.2 - ANSI/TIA-603-E-2016 – Section 2.2.12

3.2 RADIATED POWER

Test Overview

Radiated tests are performed in the Fully-anechoic chamber.
The equipment under test is placed on a non-conductive table 3-meters away from the receive antenna in accordance with ANSI/TIA-603-E-2016 Clause 2.2.17.

Test Settings

1. Radiated power measurements are performed using the signal analyzer's "channel power" measurement capability for signals with continuous operation.
2. RBW = 1 – 5 % of the expected OBW, not to exceed 1 MHz
3. VBW ≥ 3 x RBW
4. Span = 1.5 times the OBW
5. No. of sweep points > 2 x span / RBW
6. Detector = RMS
7. Trigger is set to "free run" for signals with continuous operation with the sweep times set to "auto".
8. The integration bandwidth was roughly set equal to the measured OBW of the signal for signals with continuous operation.
9. Trace mode = trace averaging (RMS) over 100 sweeps
10. The trace was allowed to stabilize

Test Note

1. The turntable is rotated through 360 degrees, and the receiving antenna scans in order to determine the level of the maximized emission.
2. A half wave dipole is then substituted in place of the EUT. For emissions above 1 GHz, a horn antenna is substituted in place of the EUT. The substitute antenna is driven by a signal generator and the previously recorded signal was duplicated.
   The power is calculated by the following formula;

$$P_{d\ (dBm)} = Pg_{\ (dBm)} - \text{cable loss}_{\ (dB)} + \text{antenna gain}_{\ (dB)}$$

   Where: P_d is the dipole equivalent power and P_g is the generator output power into the substitution antenna.
3. The maximum value is calculated by adding the forward power to the calibrated source plus its appropriate gain value.
   These steps are repeated with the receiving antenna in both vertical and horizontal polarization.
   the difference between the gain of the horn and an isotropic antenna are taken into consideration
4. The EUT was tested in three orthogonal planes(X, Y, Z) and in all possible test configurations and positioning.
5. All measurements are performed as RMS average measurements while the EUT is operating at its maximum duty cycle, at maximum power, and at the appropriate frequencies.

3.3 RADIATED SPURIOUS EMISSIONS

Test Overview

Radiated tests are performed in the Fully-anechoic chamber.

Radiated Spurious Emission Measurements at 3 meters by Substitution Method according to ANSI/TIA-603-E-2016.

Test Settings

1. RBW = 100 kHz for emissions below 1 GHz and 1 MHz for emissions above 1 GHz
2. VBW ≥ 3 x RBW
3. Span = 1.5 times the OBW
4. No. of sweep points > 2 x span / RBW
5. Detector = Peak
6. Trace mode = Max Hold
7. The trace was allowed to stabilize
8. Test channel : Low/ Middle/ High
9. Frequency range : We are performed all frequency to 10^{th} harmonics from 9 kHz.

Test Note

1. Measurements value show only up to 3 maximum emissions noted, or would be lesser if no specific emissions from the EUT are recorded (ie: margin > 20 dB from the applicable limit) and considered that's already beyond the background noise floor.
2. The EUT was tested in three orthogonal planes(X, Y, Z) and in all possible test configurations and positioning.
   The worst case emissions are reported with the EUT positioning, modulations, RB sizes and offsets, and channel bandwidth configurations shown in the test data
3. For spurious emissions above 1 GHz, a horn antenna is substituted in place of the EUT. The substitute antenna is driven by a signal generator and the previously recorded signal was duplicated.
   The spurious emissions is calculated by the following formula;

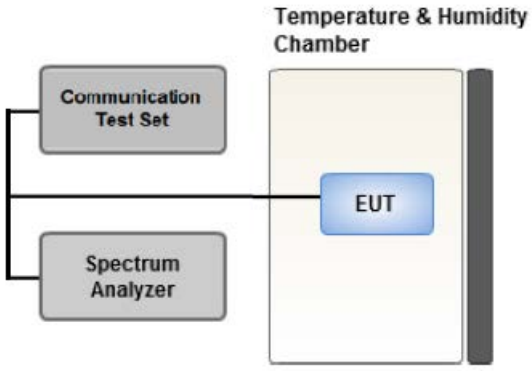
$$\text{Result}_{(dBm)} = Pg_{(dBm)} - \text{cable loss}_{(dB)} + \text{antenna gain}_{(dBi)}$$

   Where: P_g is the generator output power into the substitution antenna.

   If the fundamental frequency is below 1 GHz, RF output power has been converted to EIRP.

$$EIRP_{(dBm)} = ERP_{(dBm)} + 2.15$$

3.4 OCCUPIED BANDWIDTH.



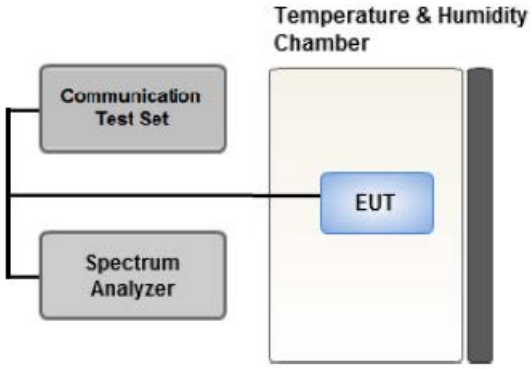
Test setup

The width of a frequency band such that, below the lower and above the upper frequency limits, the mean powers emitted are each equal to a specified percentage 0.5 % of the total mean power of a given emission.
The EUT makes a call to the communication simulator.
The conducted occupied bandwidth used the power splitter via EUT RF power connector between simulation base station and spectrum analyzer.
The communication simulator station system controlled a EUT to export maximum output power under transmission mode and specific channel frequency. Use OBW measurement function of Spectrum analyzer to measure 99 % occupied bandwidth

Test Settings

1. The signal analyzer's automatic bandwidth measurement capability was used to perform the 99 % occupied bandwidth and the 26 dB bandwidth. The bandwidth measurement was not influenced by any intermediate power nulls in the fundamental emission.
2. RBW = 1 – 5 % of the expected OBW
3. VBW ≥ 3 x RBW
4. Detector = Peak
5. Trace mode = max hold
6. Sweep = auto couple
7. The trace was allowed to stabilize
8. If necessary, steps 2 – 7 were repeated after changing the RBW such that it would be within 1 – 5 % of the 99 % occupied bandwidth observed in Step 7

3.5 SPURIOUS AND HARMONIC EMISSIONS AT ANTENNA TERMINAL



Test setup

Test Overview

The level of the carrier and the various conducted spurious and harmonic frequencies is measured by means of a calibrated spectrum analyzer. The spectrum is scanned from the lowest frequency generated in the equipment up to a frequency including its 10th harmonic.

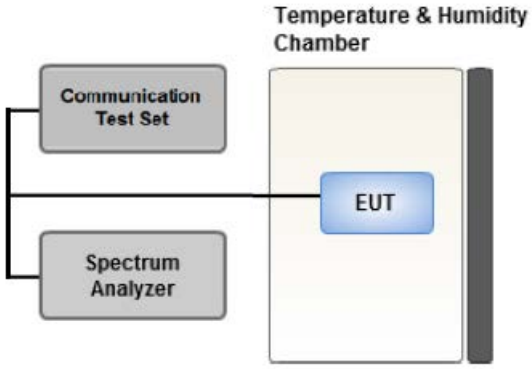
All out of band emissions are measured with a spectrum analyzer connected to the antenna terminal of the EUT while the EUT is operating at its maximum duty cycle, at maximum power, and at the appropriate frequencies.

All data rates were investigated to determine the worst case configuration. All modes of operation were investigated and the worst case configuration results are reported in this section.

Test Settings

1. RBW = 1 MHz
2. VBW ≥ 3 MHz
3. Detector = RMS
4. Trace Mode = trace average
5. Sweep time = auto
6. Number of points in sweep ≥ 2 x Span / RBW

3.6 BAND EDGE



Test setup

Test Overview

All out of band emissions are measured with a spectrum analyzer connected to the antenna terminal of the EUT while the EUT is operating at its maximum duty cycle, at maximum power, and at the appropriate frequencies. All data rates were investigated to determine the worst case configuration. All modes of operation were investigated and the worst case configuration results are reported in this section.

Test Settings

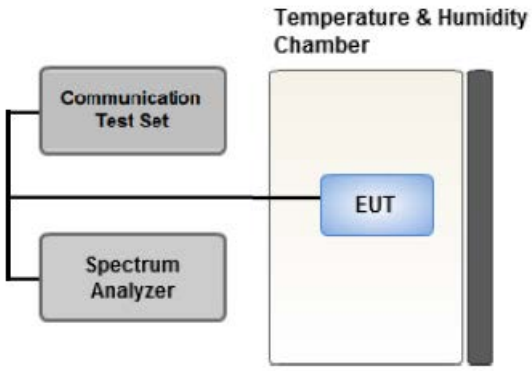
1. Start and stop frequency were set such that the band edge would be placed in the center of the plot
2. Span was set large enough so as to capture all out of band emissions near the band edge
3. RBW > 1 % of the emission bandwidth
4. VBW > 3 x RBW
5. Detector = RMS
6. Number of sweep points ≥ 2 x Span/RBW
7. Trace mode = trace average
8. Sweep time = auto couple
9. The trace was allowed to stabilize

Test Notes

According to FCC 22.917, 24.238, 27.53 specified that power of any emission outside of The authorized operating frequency ranges must be attenuated below the transmitting power (P) by a factor of at least 43 + 10 log(P) dB.
In the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed.
All measurements were done at 2 channels(low and high operational frequency range.)
The band edge measurement used the power splitter via EUT RF power connector between simulation base station and spectrum analyzer.

Where Margin < 1 dB the emission level is either corrected by 10 log(1 MHz/ RB) or the emission is integrated over a 1 MHz bandwidth to determine the final result. When using the integration method the integration window is either centered on the emission or, for emissions at the band edge, centered by an offset of 500 kHz from the block edge so that the integration window is the 1 MHz adjacent to the block edge.

3.7 FREQUENCY STABILITY / VARIATION OF AMBIENT TEMPERATURE



Test setup

Test Overview

Frequency stability testing is performed in accordance with the guidelines of ANSI C63.26-2015.

The frequency stability of the transmitter is measured by:

1. Temperature:

   The temperature is varied from -30 °C to +50 °C in 10 °C increments using an environmental chamber.

2. Primary Supply Voltage:

   .- Unless otherwise specified, vary primary supply voltage from 85 % to 115 % of the nominal value for other than hand carried battery equipment.

   .- For hand carried, battery powered equipment, reduce the primary ac or dc supply voltage to the battery operating end point, which shall be specified by the manufacturer.

Test Settings

1. The carrier frequency of the transmitter is measured at room temperature (20 °C to provide a reference).
2. The equipment is turned on in a “standby” condition for fifteen minutes before applying power to the transmitter. Measurement of the carrier frequency of the transmitter is made within one minute after applying power to the transmitter.
3. Frequency measurements are made at 10 °C intervals ranging from -30 °C to +50 °C. A period of at least one half-hour is provided to allow stabilization of the equipment at each temperature level.

3.8 WORST CASE(RADIATED TEST)

- The EUT was tested in three orthogonal planes(X, Y, Z) and in all possible test configurations and positioning.
- All modes of operation were investigated and the worst case configuration results are reported.
  Mode : Stand alone, Stand alone + External accessories (Earphone, AC adapter, etc)
  Worst case : Stand alone
- All simultaneous transmission scenarios of operation were investigated, and the test results showed no additional significant emissions relative to the least restrictive limit were observed.

  Therefore, only the worst case(stand-alone) results were reported.
- The worst case is reported with the EUT positioning, modulations, and paging service configurations shown in the test data
- Please refer to the table below.
- SM-S721B/DS & additional models were tested and the worst case results are reported.
  (Worst case : SM-S721B/DS)

[Worst case]

Test Description	Modulation	RB size	RB offset	Axis
Effective Radiated Power	QPSK, 16QAM, 64QAM, 256QAM	See Section 8.1		Y
Radiated Spurious and Harmonic Emissions	QPSK	See Section 8.2		Y

3.9 WORST CASE(CONDUCTED TEST)

- All modes of operation were investigated and the worst case configuration results are reported.
- SM-S721B/DS & additional models were tested and the worst case results are reported.
  (Worst case : SM-S721B/DS)

[Worst case]

Test Description	Modulation	Bandwidth (MHz)	Frequency	RB size	RB offset
Occupied Bandwidth	QPSK, 16QAM, 64QAM, 256QAM	5, 10	Mid	Full RB	0
Band Edge	QPSK	5	Low	1	0
			High	1	24
		10	Low	1	0
			High	1	49
		5, 10	Low, High	Full RB	0
Spurious and Harmonic Emissions at Antenna Terminal	QPSK	5, 10	Low, Mid, High	1	0

4. LIST OF TEST EQUIPMENT

Equipment	Model	Manufacturer	Serial No.	Due to Calibration	Calibration Interval
RF Switching System	FBSR-02B(1.2G HPF+LNA)	T&M SYSTEM	F1L1	12/11/2024	Annual
RF Switching System	FBSR-02B(3.3G HPF+LNA)	T&M SYSTEM	F1L2	12/11/2024	Annual
Power Splitter(DC ~ 26.5 GHz)	11667B	Hewlett Packard	5001	04/17/2025	Annual
DC Power Supply	E3632A	Hewlett Packard	MY40004427	08/25/2024	Annual
Dipole Antenna	UHAP	Schwarzbeck	557	03/09/2025	Biennial
Dipole Antenna	UHAP	Schwarzbeck	558	03/09/2025	Biennial
Chamber	SU-642	ESPEC	93008124	02/19/2025	Annual
Horn Antenna(1 ~ 18 GHz)	BBHA 9120D	Schwarzbeck	147	08/17/2025	Biennial
Horn Antenna(1 ~ 18 GHz)	BBHA 9120D	Schwarzbeck	9120D-1298	09/11/2025	Biennial
Horn Antenna(15 ~ 40 GHz)	BBHA 9170	Schwarzbeck	BBHA9170342	09/29/2024	Biennial
Horn Antenna(15 ~ 40 GHz)	BBHA 9170	Schwarzbeck	BBHA9170124	03/28/2025	Biennial
Signal Analyzer(10 Hz ~ 26.5 GHz)	N9020A	Agilent	MY52090906	04/19/2025	Annual
ATTENUATOR(20 dB)	8493C	Hewlett Packard	17280	04/17/2025	Annual
Spectrum Analyzer(10 Hz ~ 40 GHz)	FSV40	REOHDE & SCHWARZ	100931	08/17/2024	Annual
Base Station	8960 (E5515C)	Agilent	MY48360800	08/10/2024	Annual
Loop Antenna(9 kHz ~ 30 MHz)	FMZB1513	Schwarzbeck	1513-333	03/07/2026	Biennial
Trilog Broadband Antenna	VULB9168	Schwarzbeck	895	09/16/2024	Biennial
Trilog Broadband Antenna	VULB9168	Schwarzbeck	1135	09/16/2024	Biennial
Wideband Radio Communication Tester	MT8821C	Anritsu Corp.	6262094331	11/17/2024	Annual
Wideband Radio Communication Tester	MT8820C	Anritsu Corp.	6201026545	12/11/2024	Annual
Signal Analyzer(5 Hz ~ 40.0 GHz)	N9030B	KEYSIGHT	MY55480167	05/17/2025	Annual
FCC LTE Mobile Conducted RF Automation Test Software	-	HCT CO., LTD.,	-	-	-

Note:

1. Equipment listed above that has a calibration due date during the testing period, the testing is completed before equipment expiration date.
2. Especially, all antenna for measurement is calibrated in accordance with the requirements of C63.5 (Version : 2017).

5. MEASUREMENT UNCERTAINTY

The measurement uncertainties shown below were calculated in accordance with the requirements of ANSI C63.4:2014.

All measurement uncertainty values are shown with a coverage factor of $k = 2$ to indicate a 95 % level of confidence. The measurement data shown herein meets or exceeds the U_{CISPR} measurement uncertainty values specified in CISPR 16-4-2 and, thus, can be compared directly to specified limits to determine compliance.

Parameter	Expanded Uncertainty (±dB)
Conducted Disturbance (150 kHz ~ 30 MHz)	1.98 (Confidence level about 95 %, k=2)
Radiated Disturbance (9 kHz ~ 30 MHz)	4.36 (Confidence level about 95 %, k=2)
Radiated Disturbance (30 MHz ~ 1 GHz)	5.70 (Confidence level about 95 %, k=2)
Radiated Disturbance (1 GHz ~ 18 GHz)	5.52 (Confidence level about 95 %, k=2)
Radiated Disturbance (18 GHz ~ 40 GHz)	5.66 (Confidence level about 95 %, k=2)
Radiated Disturbance (Above 40 GHz)	5.58 (Confidence level about 95 %, k=2)

6. SUMMARY OF TEST RESULTS

6.1 Test Condition: Conducted Test

Test Description	FCC Part Section(s)	Test Limit	Test Result
Occupied Bandwidth	§ 2.1049	N/A	PASS
Band Edge / Spurious and Harmonic Emissions at Antenna Terminal.	§ 2.1051, § 27.53(c)	< 43 + 10log10 (P[Watts]) at Band Edge and for all out-of-band emissions	PASS
On all frequencies between 763-775 MHz and 793-805 MHz.	§ 27.53(c)(4)	< 65 + 10log10 (P[Watts])	PASS (See Note2)
Conducted Output Power	§ 2.1046	N/A	See Note1
Frequency stability / variation of ambient temperature	§ 2.1055, § 27.54	Emission must remain in band	PASS

Note:

1. See SAR Report
2. Since it was not possible to set the resolution bandwidth to 6.25 kHz with the available equipment, a bandwidth of 10 kHz was used instead to show compliance.

6.2 Test Condition: Radiated Test

Test Description	FCC Part Section(s)	Test Limit	Test Result
Effective Radiated Power	§ 27.50(b)(10)	< 3 Watts max. ERP	PASS
Radiated Spurious and Harmonic Emissions	§ 2.1053, § 27.53(c)	< 43 + 10log10 (P[Watts]) for all out-of band emissions	PASS
Undesirable Emissions in the 1559 – 1610 MHz band	§ 2.1053, 27.53(f)	< -70dBW/MHz EIRP (wideband) < -80dBW EIRP (narrowband)	PASS

7. SAMPLE CALCULATION

7.1 ERP Sample Calculation

Ch./ Freq.		Measured Level (dBm)	Substitute Level (dBm)	Ant. Gain (dBd)	C.L	Pol.	ERP	
channel	Freq.(MHz)						W	dBm
128	824.20	-21.37	38.40	-10.61	0.95	H	0.483	26.84

ERP = Substitute LEVEL(dBm) + Ant. Gain – CL(Cable Loss)

1) The EUT mounted on a non-conductive turntable is 2.5 meter above test site ground level.
2) During the test, the turn table is rotated until the maximum signal is found.
3) Record the field strength meter's level.
4) Replace the EUT with dipole/Horn antenna that is connected to a calibrated signal generator.
5) Increase the signal generator output till the field strength meter's level is equal to the item (3).
6) The signal generator output level with Ant. Gain and cable loss are the rating of effective radiated power.

7.2 EIRP Sample Calculation

Ch./ Freq.		Measured Level (dBm)	Substitute Level (dBm)	Ant. Gain (dBi)	C.L	Pol.	EIRP	
channel	Freq.(MHz)						W	dBm
20175	1,732.50	-15.75	18.45	9.90	1.76	H	0.456	26.59

EIRP = Substitute LEVEL(dBm) + Ant. Gain – CL(Cable Loss)

1) The EUT mounted on a non-conductive turntable is 2.5 meter above test site ground level.
2) During the test, the turn table is rotated until the maximum signal is found.
3) Record the field strength meter's level.
4) Replace the EUT with dipole/Horn antenna that is connected to a calibrated signal generator.
5) Increase the signal generator output till the field strength meter's level is equal to the item (3).
6) The signal generator output level with Ant. Gain and cable loss are the rating of equivalent isotropic radiated power.

7.3. Emission Designator

GSM Emission Designator

Emission Designator = 249KGXW
GSM BW = 249 kHz
G = Phase Modulation
X = Cases not otherwise covered
W = Combination (Audio/Data)

EDGE Emission Designator

Emission Designator = 249KG7W
GSM BW = 249 kHz
G = Phase Modulation
7 = Quantized/Digital Info
W = Combination (Audio/Data)

WCDMA Emission Designator

Emission Designator = 4M17F9W
WCDMA BW = 4.17 MHz
F = Frequency Modulation
9 = Composite Digital Info
W = Combination (Audio/Data)

QPSK Modulation

Emission Designator = 4M48G7D
LTE BW = 4.48 MHz
G = Phase Modulation
7 = Quantized/Digital Info
D = Data transmission; telemetry; telecommand

QAM Modulation

Emission Designator = 4M48W7D
LTE BW = 4.48 MHz
W = Amplitude/Angle Modulated
7 = Quantized/Digital Info
D = Data transmission; telemetry; telecommand

8. TEST DATA

8.1 EFFECTIVE RADIATED POWER

Freq (MHz)	Mod/ Bandwidth	Modulation	Measured Level (dBm)	Substitute Level (dBm)	Ant. Gain (dBd)	C.L	Pol	Limit	ERP		RB	
								W	W	dBm	Size	Offset
779.5	LTE B13 (5 MHz)	QPSK	-30.78	31.55	-9.85	1.36	V	< 3.00	0.108	20.34	1	0
		16-QAM	-32.62	29.71	-9.85	1.36	V		0.071	18.50		
		64-QAM	-33.50	28.83	-9.85	1.36	V		0.058	17.62		
		256-QAM	-34.61	27.72	-9.85	1.36	V		0.045	16.51		
782.0		QPSK	-31.11	31.38	-9.85	1.36	V		0.104	20.17	1	0
		16-QAM	-32.78	29.71	-9.85	1.36	V		0.071	18.50		
		64-QAM	-33.88	28.61	-9.85	1.36	V		0.055	17.40		
		256-QAM	-34.91	27.58	-9.85	1.36	V		0.043	16.37		
784.5		QPSK	-30.93	31.65	-9.85	1.36	V		0.111	20.44	1	24
		16-QAM	-32.75	29.83	-9.85	1.36	V		0.073	18.62		
		64-QAM	-33.67	28.91	-9.85	1.36	V		0.059	17.70		
		256-QAM	-34.80	27.78	-9.85	1.36	V		0.045	16.57		

Freq (MHz)	Mod/ Bandwidth	Modulation	Measured Level (dBm)	Substitute Level (dBm)	Ant. Gain (dBd)	C.L	Pol	Limit	ERP		RB	
								W	W	dBm	Size	Offset
782.0	LTE B13 (10 MHz)	QPSK	-30.92	31.57	-9.85	1.36	V	< 3.00	0.109	20.36	1	0
		16-QAM	-32.78	29.71	-9.85	1.36	V		0.071	18.50		
		64-QAM	-33.65	28.84	-9.85	1.36	V		0.058	17.63		
		256-QAM	-34.76	27.73	-9.85	1.36	V		0.045	16.52		

8.2 RADIATED SPURIOUS EMISSIONS

▣ MODE: LTE B13

▣ MODULATION SIGNAL: 5 MHz QPSK

▣ DISTANCE: 3 meters

Ch	Freq (MHz)	Measured Level (dBm)	Ant. Gain (dBd)	Substitute Level (dBm)	C.L	Pol	Result (dBm)	Limit (dBm)	RB	
									Size	Offset
23205 (779.5)	1 559.0	-58.73	8.40	-66.06	1.94	V	-59.60	-40.00	1	0
	2 338.5	-53.98	10.00	-59.50	2.45	V	-51.95	-13.00		
	3 118.0	-59.01	10.20	-61.38	2.81	V	-53.99	-13.00		
23230 (782.0)	1 564.0	-58.30	8.40	-65.70	1.96	V	-59.26	-40.00	1	0
	2 346.0	-54.12	10.10	-59.94	2.47	H	-52.31	-13.00		
	3 128.0	-61.74	10.20	-64.09	2.82	V	-56.71	-13.00		
23255 (784.5)	1 569.0	-58.37	8.40	-65.84	1.98	V	-59.42	-40.00	1	24
	2 353.5	-53.79	10.20	-59.48	2.48	H	-51.76	-13.00		
	3 138.0	-59.14	10.20	-60.81	2.84	V	-53.45	-13.00		

▣ MODE: LTE B13

▣ MODULATION SIGNAL: 10 MHz QPSK

▣ DISTANCE: 3 meters

Ch	Freq (MHz)	Measured Level (dBm)	Ant. Gain (dBd)	Substitute Level (dBm)	C.L	Pol	Result (dBm)	Limit (dBm)	RB	
									Size	Offset
23230 (782.0)	1 564.0	-58.23	8.40	-65.63	1.96	V	-59.19	-40.00	1	0
	2 346.0	-54.85	10.10	-60.67	2.47	H	-53.04	-13.00		
	3 128.0	-59.98	10.20	-62.33	2.82	V	-54.95	-13.00		

1559 MHz ~ 1610 MHz BAND

▣ OPERATING FREQUENCY: 779.5 MHz, 782.0 MHz, 784.5 MHz

▣ MEASURED OUTPUT POWER: 5 MHz QPSK

▣ DISTANCE: 3 meters

▣ WIDEBAND EMISSION LIMIT: -70 dBW/ MHz (= -40 dBm/ MHz)

Operating Frequency (MHz)	Measured Frequency (MHz)	EMISSION TYPE	Measured Level (dBm)	Ant. Gain (dBi)	Substitute Level (dBm)	C.L	Pol	Result (dBm)	Margin (dB)
779.5	1 587.60	Wide Band	-55.40	8.40	-62.98	1.99	V	-56.57	16.57
782.0	1 599.50		-55.17	8.70	-63.04	1.96	V	-56.30	16.30
784.5	1 584.60		-55.01	8.40	-62.88	1.99	V	-56.47	16.47

Note:

Since the bandwidth of that Spurious emission is greater than 700 Hz, we applied -70 dBW/MHz according to § 27.53(f).

▣ OPERATING FREQUENCY: 782.0 MHz

▣ MEASURED OUTPUT POWER: 10 MHz QPSK

▣ DISTANCE: 3 meters

▣ WIDEBAND EMISSION LIMIT: -70 dBW/ MHz (= -40 dBm/ MHz)

Operating Frequency (MHz)	Measured Frequency (MHz)	EMISSION TYPE	Measured Level (dBm)	Ant. Gain (dBi)	Substitute Level (dBm)	C.L	Pol	Result (dBm)	Margin (dB)
782.0	1 597.70	Wide Band	-55.32	8.70	-63.19	1.96	V	-56.45	16.45

Note:

Since the bandwidth of that Spurious emission is greater than 700 Hz, we applied -70 dBW/MHz according to § 27.53(f).

8.3 OCCUPIED BANDWIDTH

Band	Band Width	Frequency (MHz)	Modulation	Resource Block Size	Resource Block Offset	Data (MHz)
13	5 MHz	782.0	QPSK	25	0	4.5041
			16-QAM			4.5288
			64-QAM			4.5072
			256-QAM			4.5105
	10 MHz		QPSK	50		9.0212
			16-QAM			9.0090
			64-QAM			9.0260
			256-QAM			9.0029

Note:

1. Plots of the EUT's Occupied Bandwidth are shown Page 34 ~ 41.

8.4 CONDUCTED SPURIOUS EMISSIONS

Band	Band Width (MHz)	Frequency (MHz)	Frequency of Maximum Harmonic (GHz)	Factor (dB)	Measurement Maximum Data (dBm)	Result (dBm)	Limit (dBm)
13	5	779.5	3.7049	27.976	-67.055	-39.079	-13.00
		782.0	3.6955	27.976	-67.163	-39.187	
		784.5	3.1706	27.976	-67.110	-39.134	
	10	782.0	3.7074	27.976	-67.111	-39.135	

Note:

1. Plots of the EUT's Conducted Spurious Emissions are shown Page 42 ~ 45.
2. Conducted Spurious Emissions was Tested QPSK Modulation, Resource Block Size 1 and Resource Block Offset 0
3. Result (dBm) = Measurement Maximum Data (dBm) + Factor (dB)
4. Factor (dB) = Cable Loss + Attenuator + Power Splitter

Frequency Range (GHz)	Factor [dB]
0.03 – 1	25.270
1 – 5	27.976
5 – 10	28.591
10 – 15	29.116
15 – 20	29.489
Above 20(26.5)	30.131

8.5 BAND EDGE

- Plots of the EUT's Band Edge are shown Page 46 ~ 57.

8.6 FREQUENCY STABILITY / VARIATION OF AMBIENT TEMPERATURE

▣ MODE: LTE 13

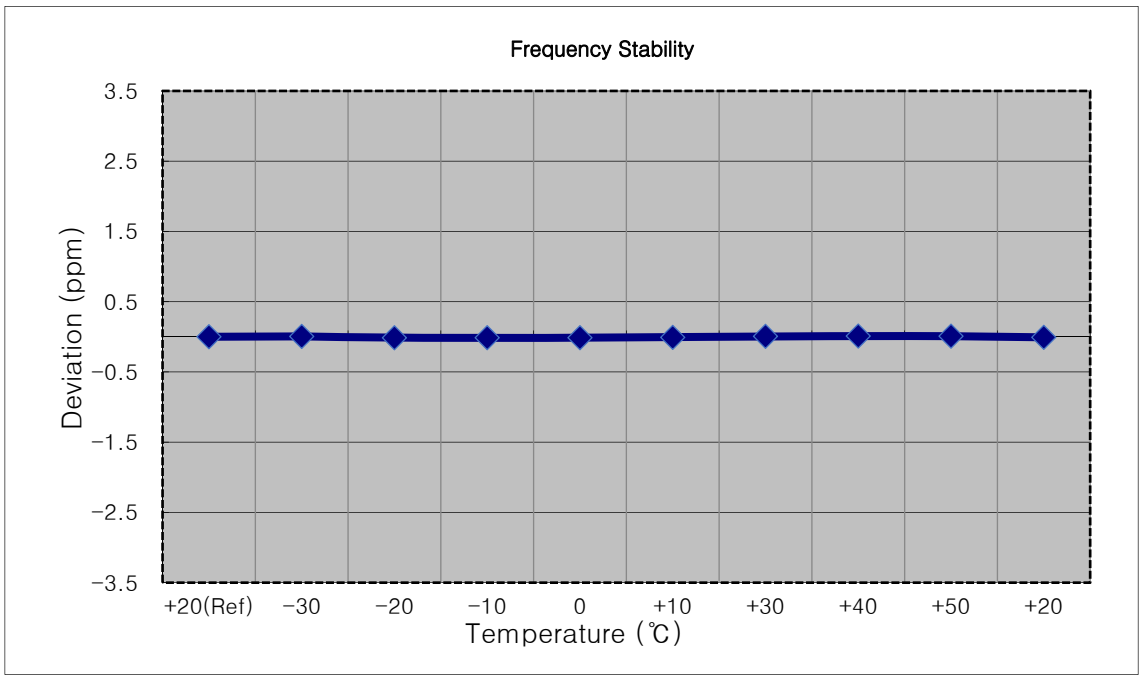
▣ OPERATING FREQUENCY: 779,500,000 Hz

▣ CHANNEL: 23205 (5 MHz)

▣ REFERENCE VOLTAGE: 3.880 VDC

▣ DEVIATION LIMIT: Emission must remain in band

Voltage	Power	Temp.	Frequency	Frequency Error	Deviation	ppm
(%)	(VDC)	(℃)	(Hz)	(Hz)	(%)	
100 %	3.880	+20(Ref)	779 499 992	0.00	0.000 000	0.0000
100 %		-30	779 499 996	4.00	0.000 001	0.0051
100 %		-20	779 499 981	-11.20	-0.000 001	-0.0144
100 %		-10	779 499 982	-10.10	-0.000 001	-0.0130
100 %		0	779 499 982	-10.40	-0.000 001	-0.0133
100 %		+10	779 499 985	-7.10	-0.000 001	-0.0091
100 %		+30	779 499 998	5.20	0.000 001	0.0067
100 %		+40	779 500 001	8.10	0.000 001	0.0104
100 %		+50	779 499 999	6.80	0.000 001	0.0087
Batt. Endpoint	3.300	+20	779 499 986	-6.00	-0.000 001	-0.0077



▣ MODE: LTE 13

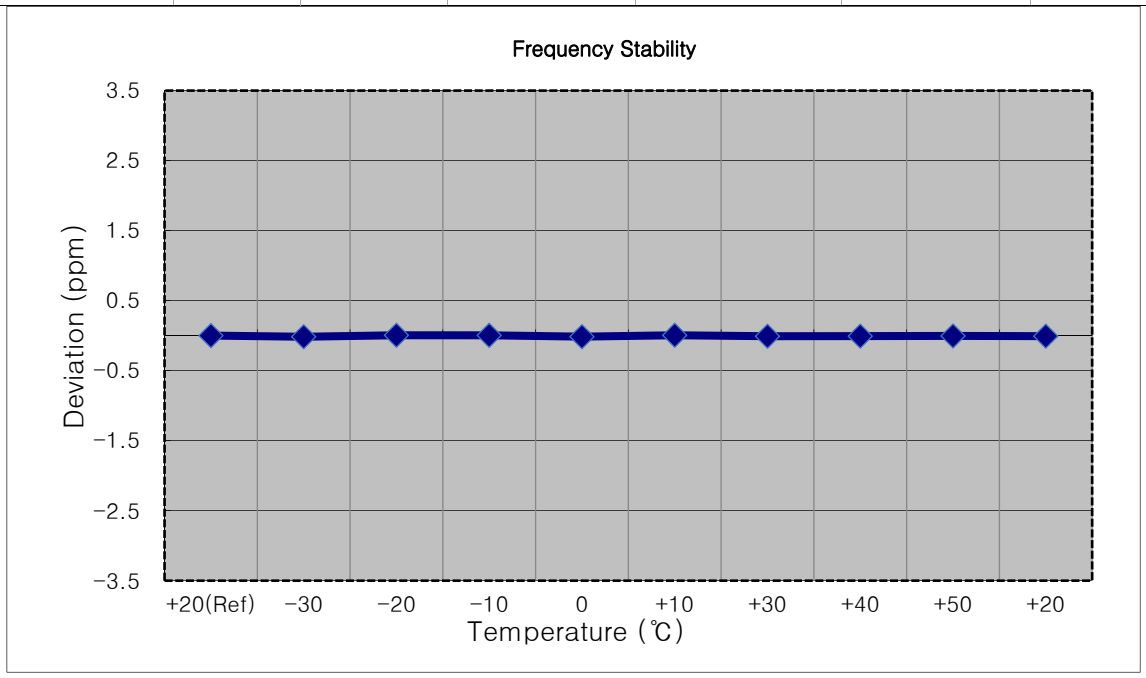
▣ OPERATING FREQUENCY: 782,000,000 Hz

▣ CHANNEL: 23230 (5 MHz)

▣ REFERENCE VOLTAGE: 3.880 VDC

▣ DEVIATION LIMIT: Emission must remain in band

Voltage	Power	Temp.	Frequency	Frequency Error	Deviation	ppm
(%)	(VDC)	(℃)	(Hz)	(Hz)	(%)	
100 %	3.880	+20(Ref)	782 000 009	0.00	0.000 000	0.0000
100 %		-30	781 999 996	-12.60	-0.000 002	-0.0161
100 %		-20	782 000 012	3.70	0.000 000	0.0047
100 %		-10	782 000 012	3.00	0.000 000	0.0038
100 %		0	781 999 996	-12.10	-0.000 002	-0.0155
100 %		+10	782 000 013	4.10	0.000 001	0.0052
100 %		+30	782 000 001	-7.30	-0.000 001	-0.0093
100 %		+40	782 000 002	-6.10	-0.000 001	-0.0078
100 %		+50	782 000 005	-3.50	0.000 000	-0.0045
Batt. Endpoint	3.300	+20	782 000 002	-6.20	-0.000 001	-0.0079



▣ MODE: LTE 13

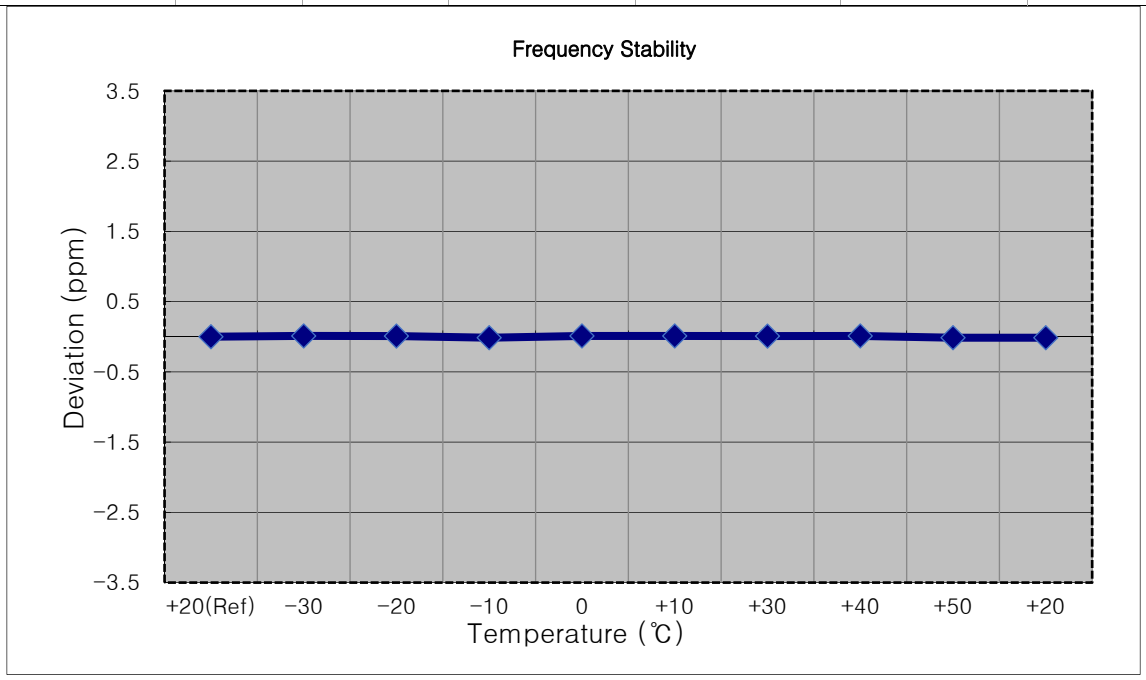
▣ OPERATING FREQUENCY: 784,500,000 Hz

▣ CHANNEL: 23255 (5 MHz)

▣ REFERENCE VOLTAGE: 3.880 VDC

▣ DEVIATION LIMIT: Emission must remain in band

Voltage	Power	Temp.	Frequency	Frequency Error	Deviation	ppm
(%)	(VDC)	(℃)	(Hz)	(Hz)	(%)	
100 %	3.880	+20(Ref)	784 499 989	0.00	0.000 000	0.0000
100 %		-30	784 499 998	8.80	0.000 001	0.0112
100 %		-20	784 499 997	7.50	0.000 001	0.0096
100 %		-10	784 499 978	-11.00	-0.000 001	-0.0140
100 %		0	784 499 998	8.90	0.000 001	0.0113
100 %		+10	784 499 998	8.50	0.000 001	0.0108
100 %		+30	784 499 996	7.10	0.000 001	0.0091
100 %		+40	784 499 998	8.60	0.000 001	0.0110
100 %		+50	784 499 978	-10.90	-0.000 001	-0.0139
Batt. Endpoint	3.300	+20	784 499 978	-10.90	-0.000 001	-0.0139



▣ MODE: LTE 13

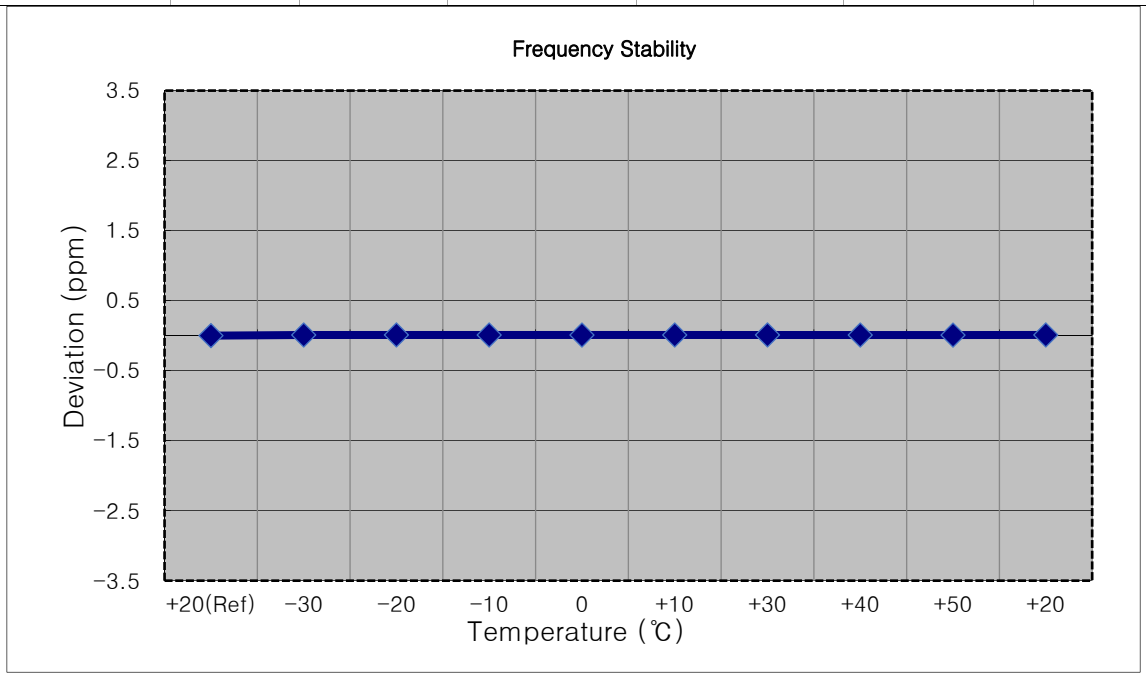
▣ OPERATING FREQUENCY: 782,000,000 Hz

▣ CHANNEL: 23230 (10 MHz)

▣ REFERENCE VOLTAGE: 3.880 VDC

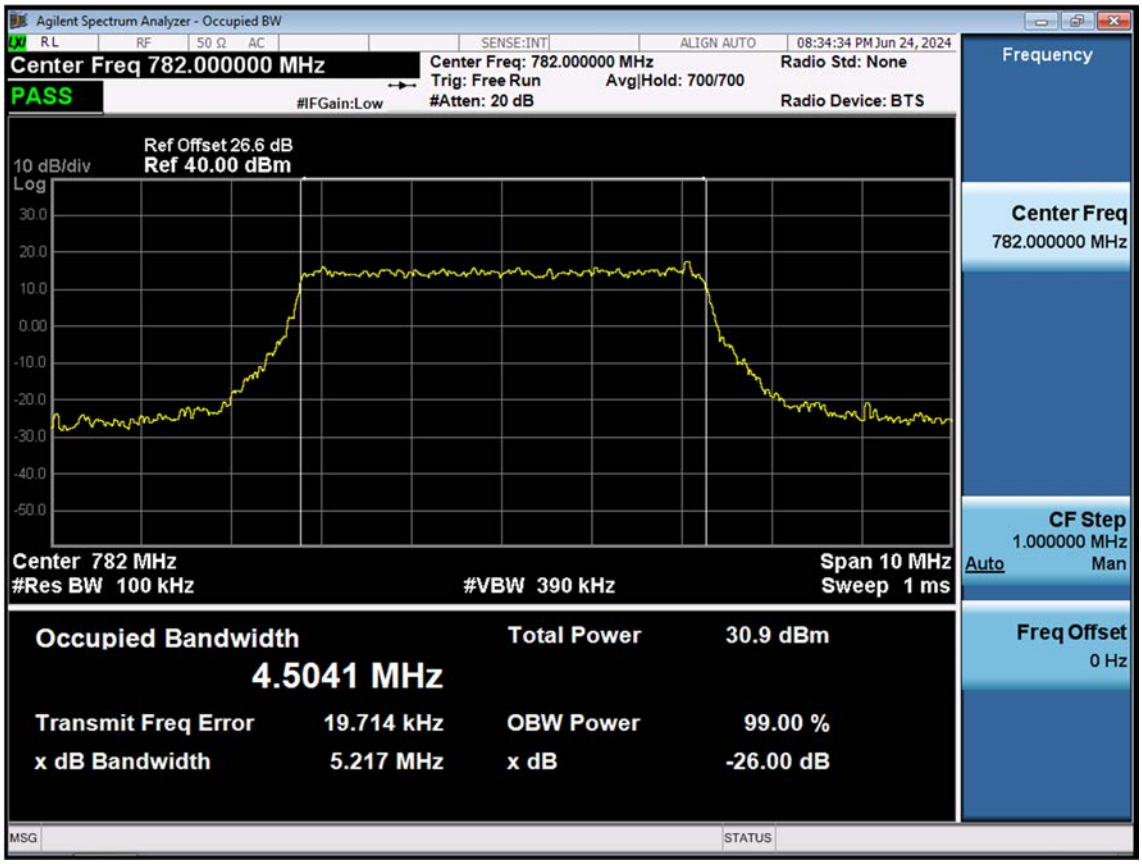
▣ DEVIATION LIMIT: Emission must remain in band

Voltage	Power	Temp.	Frequency	Frequency Error	Deviation	ppm
(%)	(VDC)	(℃)	(Hz)	(Hz)	(%)	
100 %	3.880	+20(Ref)	781 999 992	0.00	0.000 000	0.0000
100 %		-30	781 999 999	6.80	0.000 001	0.0087
100 %		-20	782 000 000	7.50	0.000 001	0.0096
100 %		-10	782 000 000	7.10	0.000 001	0.0091
100 %		0	781 999 999	6.20	0.000 001	0.0079
100 %		+10	781 999 999	6.80	0.000 001	0.0087
100 %		+30	782 000 000	7.50	0.000 001	0.0096
100 %		+40	781 999 999	6.30	0.000 001	0.0081
100 %		+50	781 999 998	6.00	0.000 001	0.0077
Batt. Endpoint	3.300	+20	782 000 000	7.30	0.000 001	0.0093

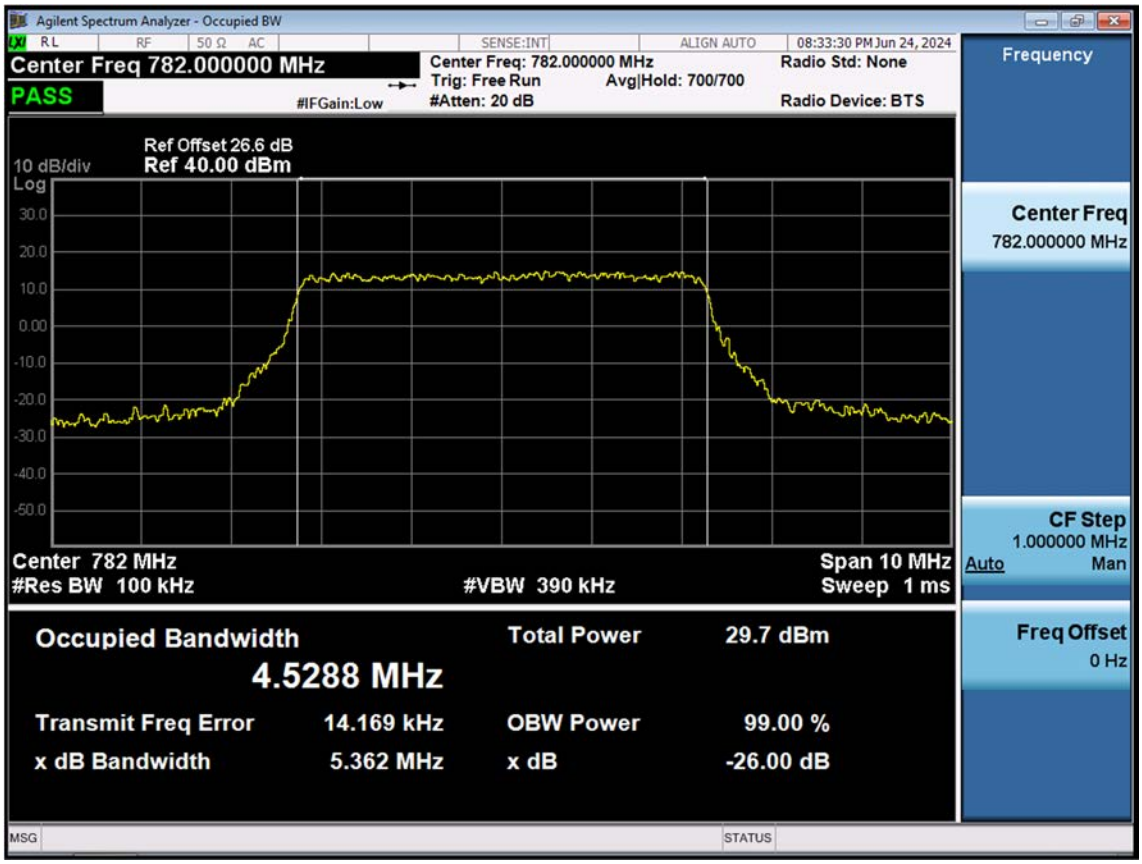


9. TEST PLOTS

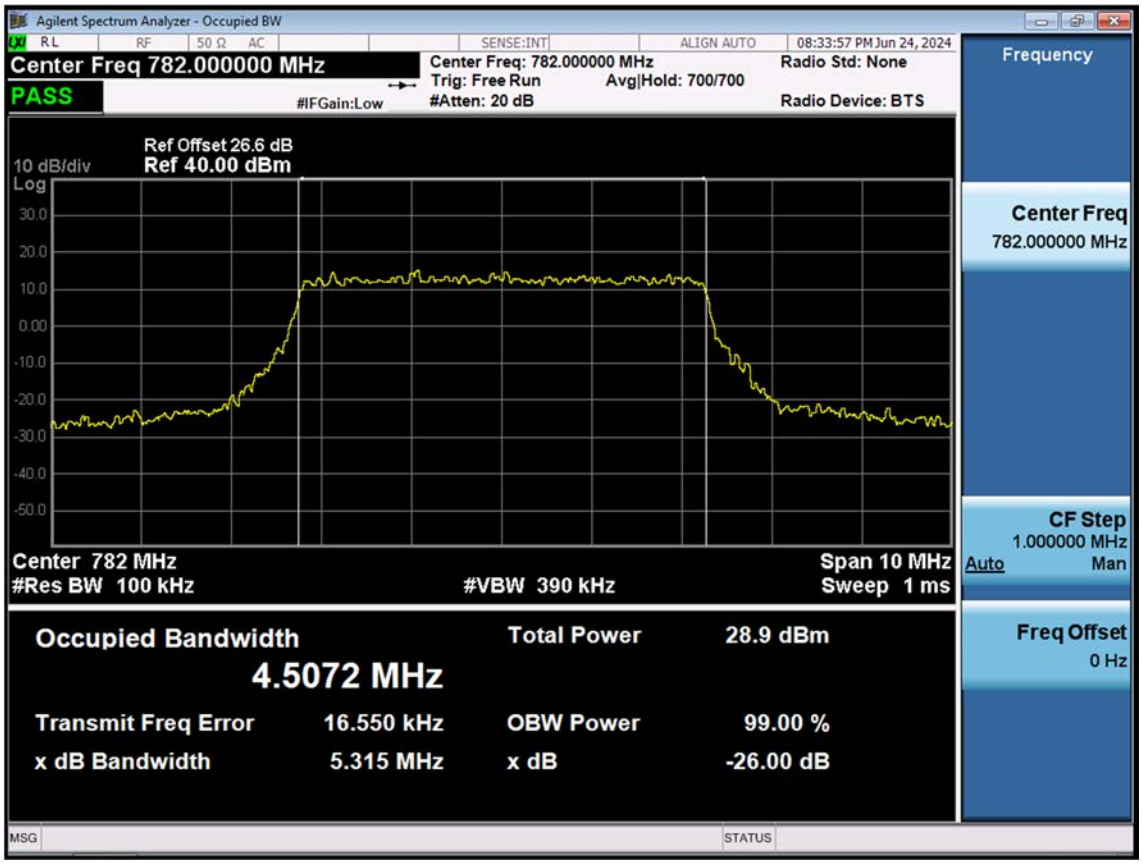
LTE B13_5 M_OBW_Mid_QPSK_FullRB



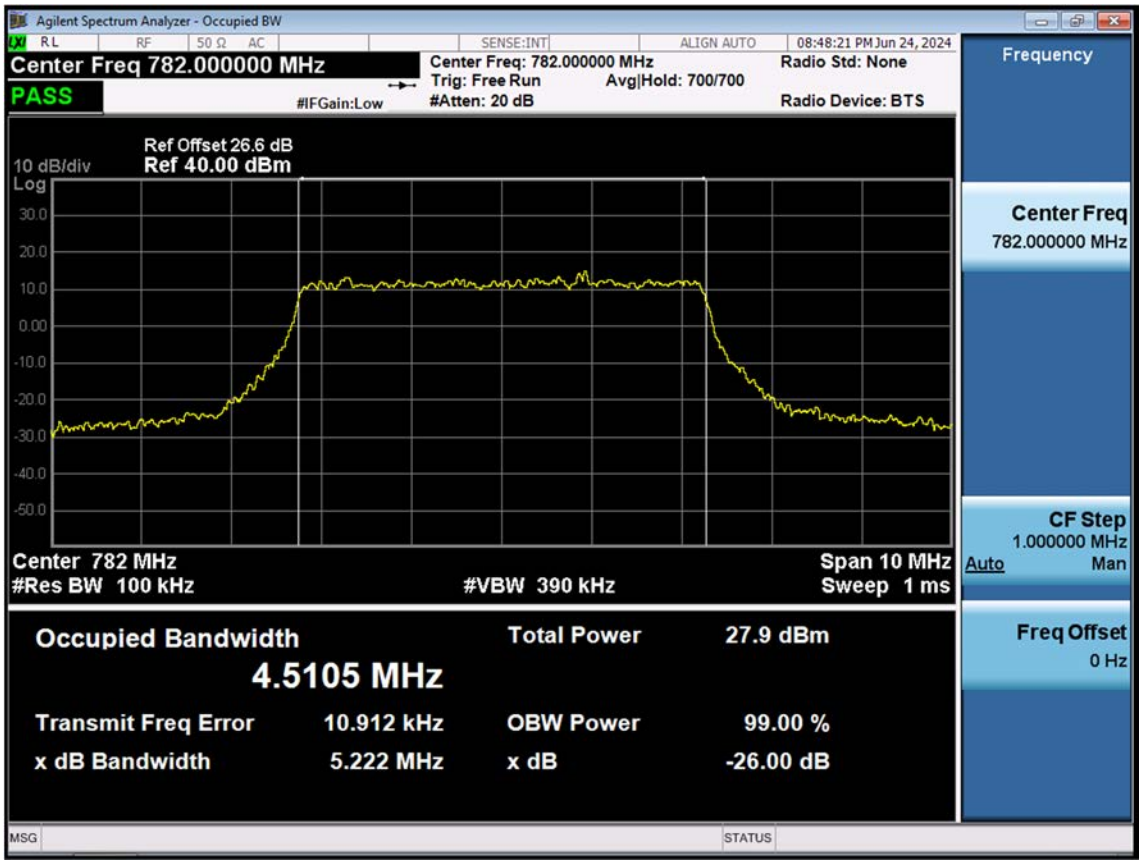
LTE B13_5 M_OBW_Mid_16QAM_FullRB



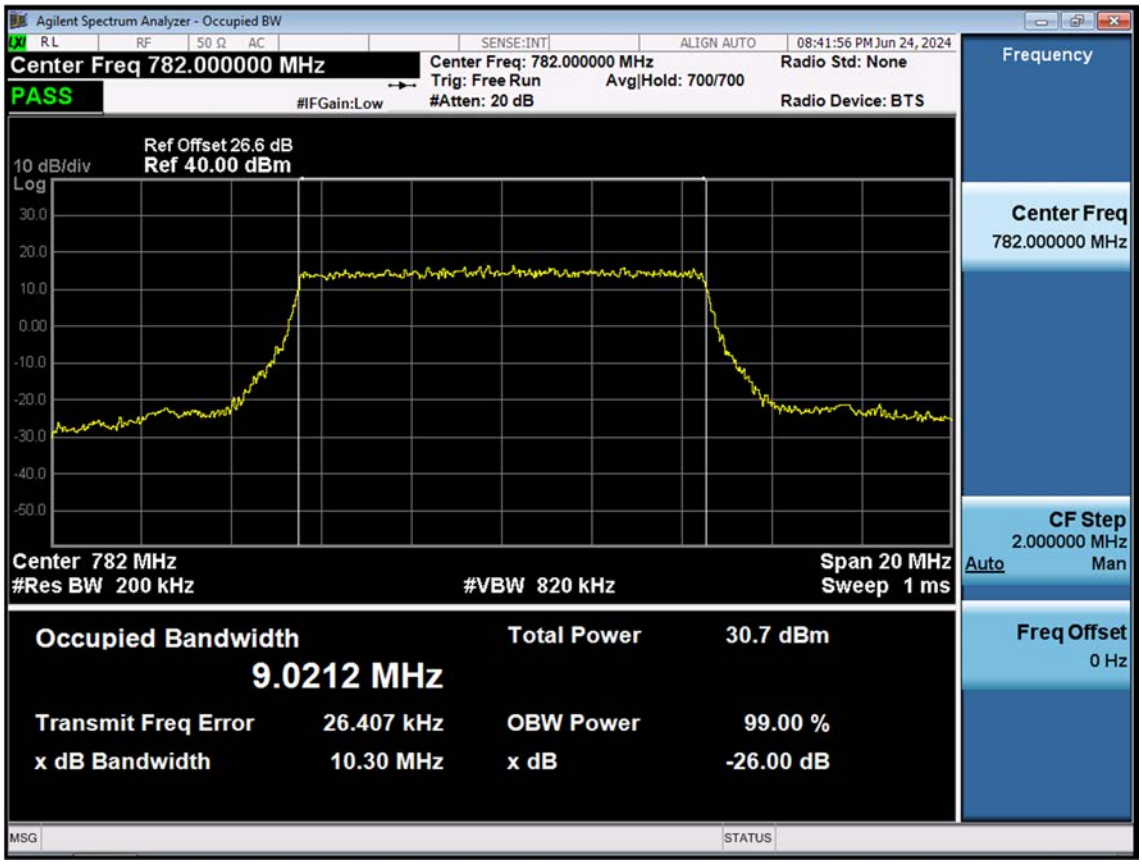
LTE B13_5 M_OBW_Mid_64QAM_FullRB



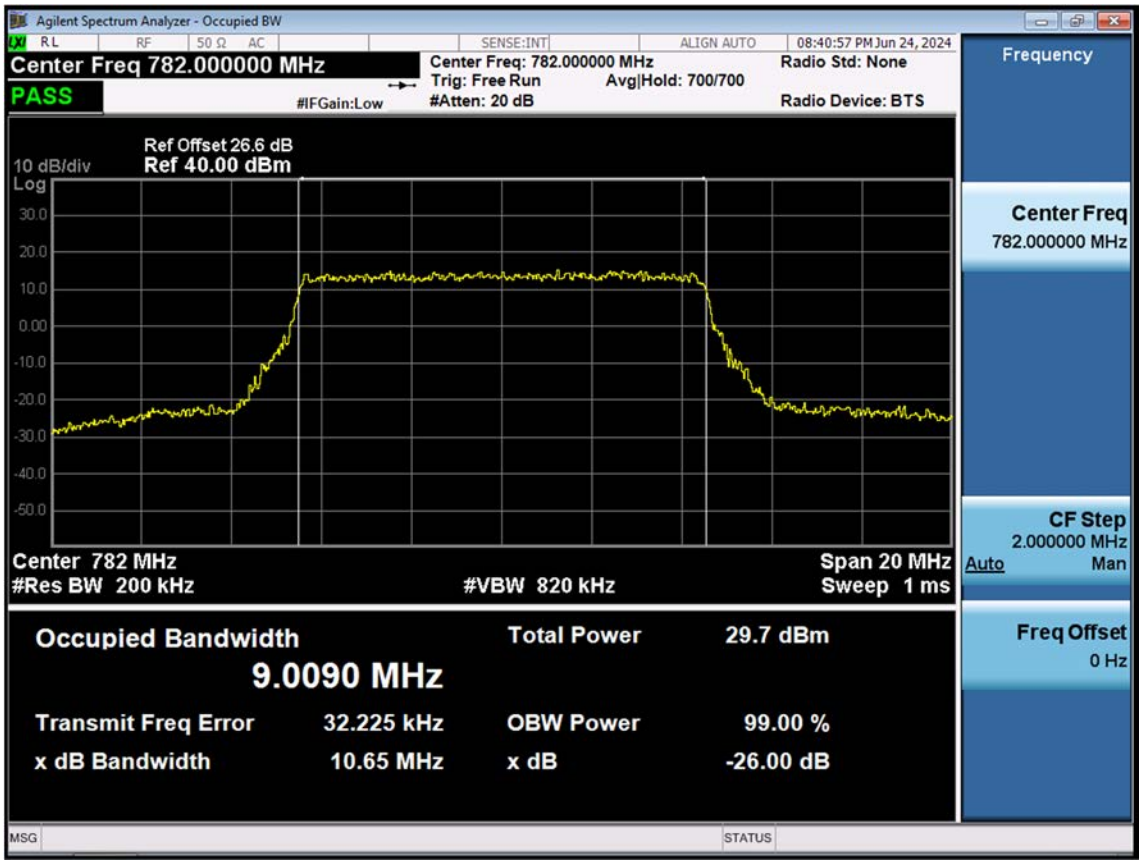
LTE B13_5 M_OBW_Mid_256QAM_FullRB



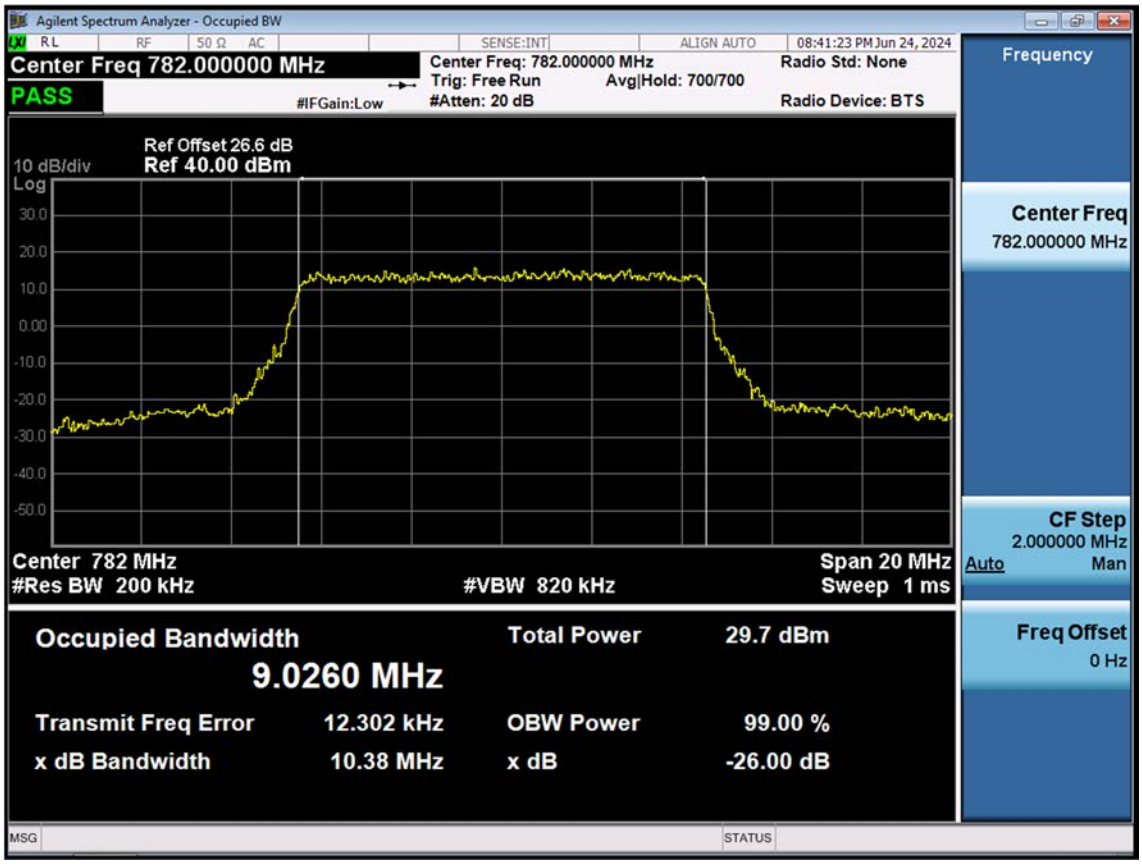
LTE B13_10 M_OBW_Mid_QPSK_FullRB



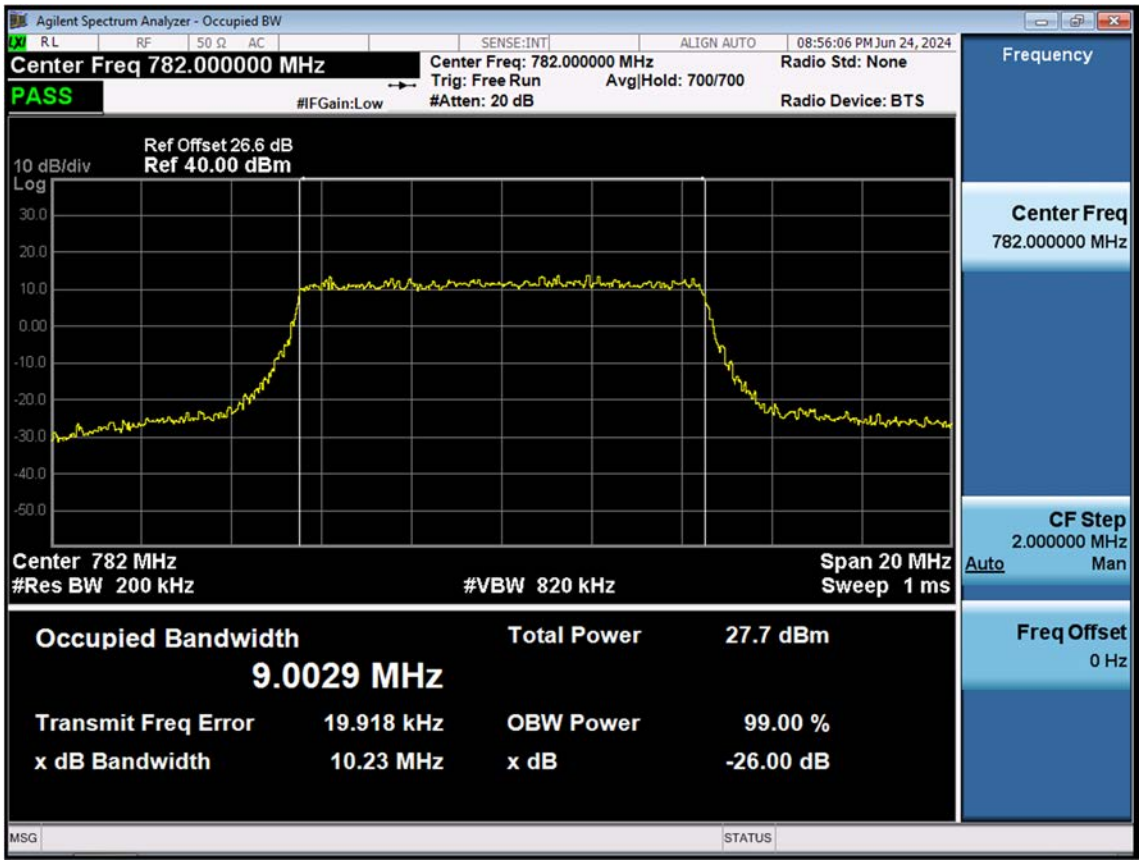
LTE B13_10 M_OBW_Mid_16QAM_FullRB



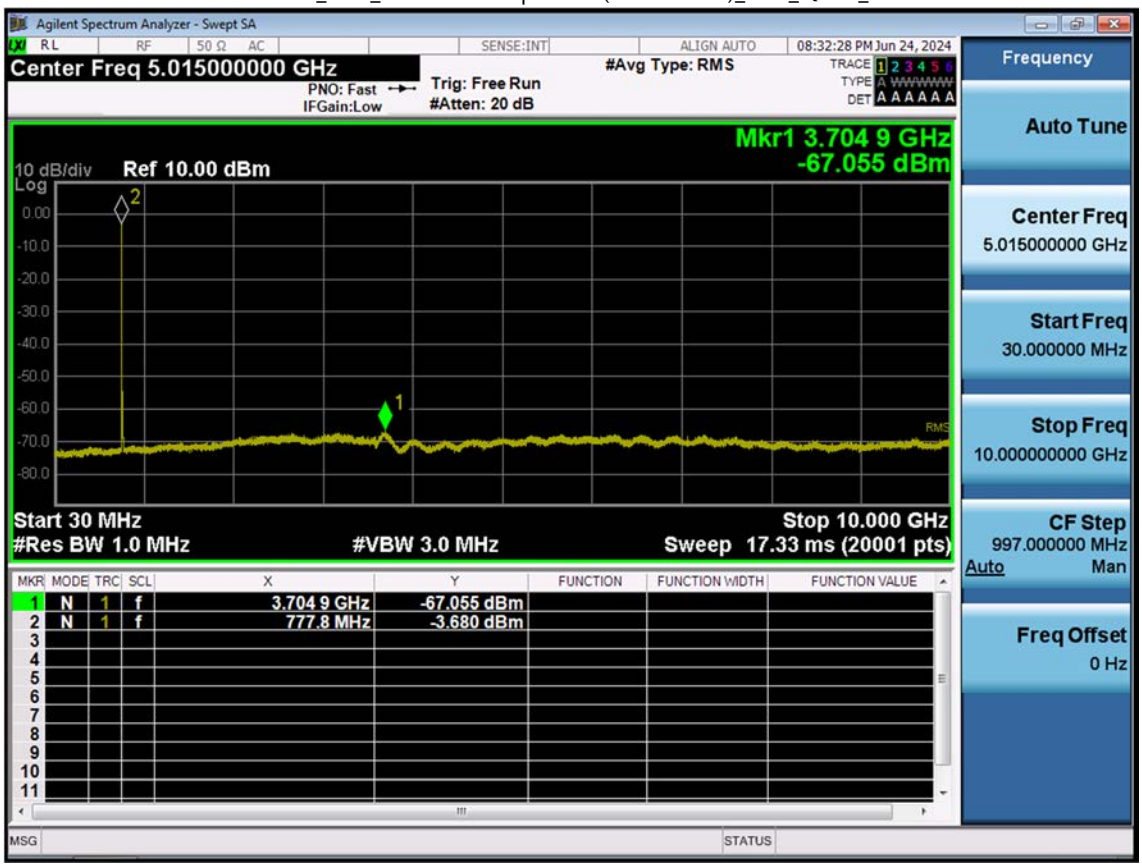
LTE B13_10 M_OBW_Mid_64QAM_FullRB



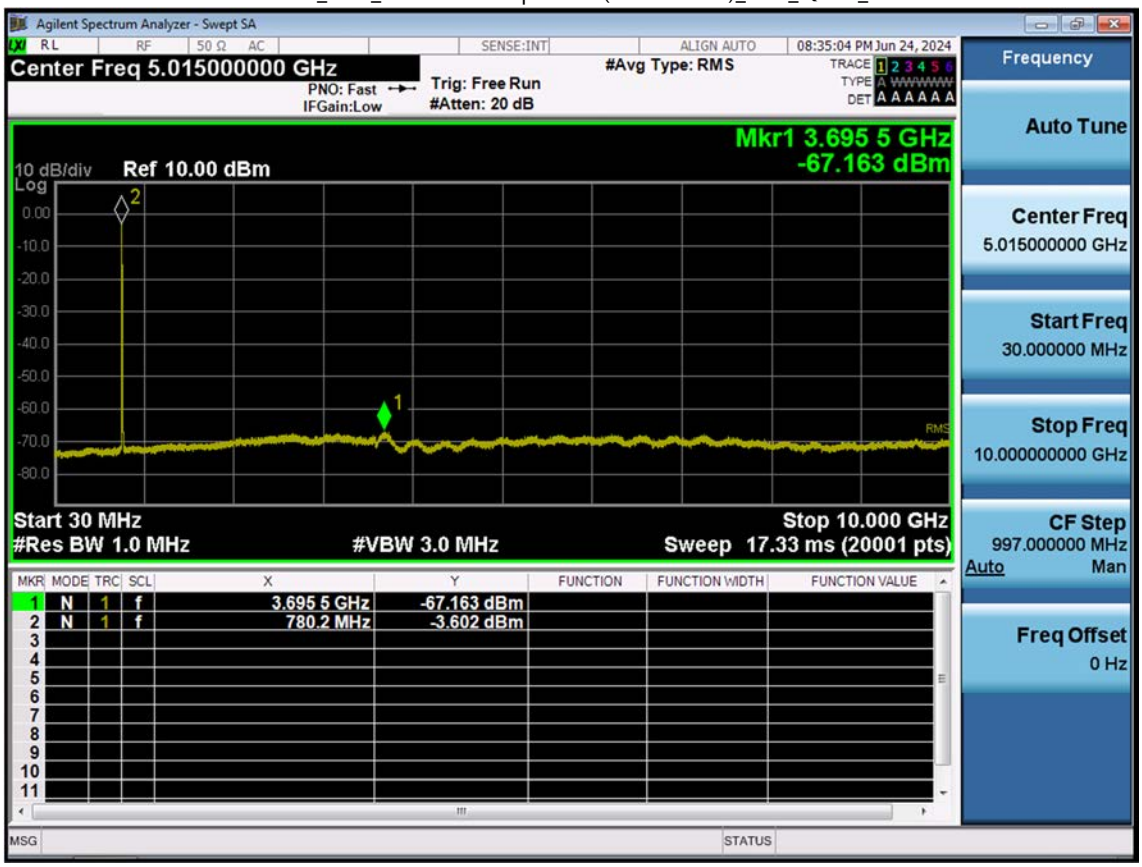
LTE B13_10 M_OBW_Mid_256QAM_FullRB



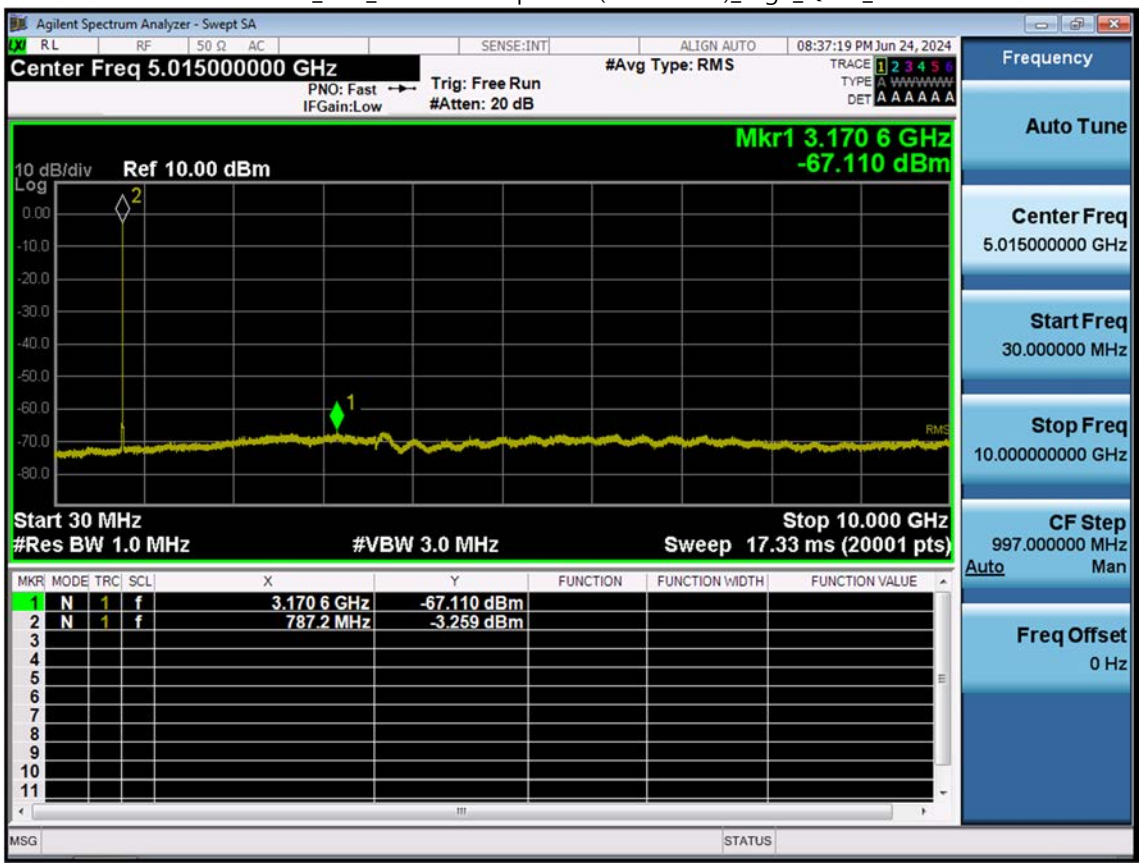
LTE B13_5 M_Conducted Spurious(30 M-10 G)_Low_QPSK_1RB



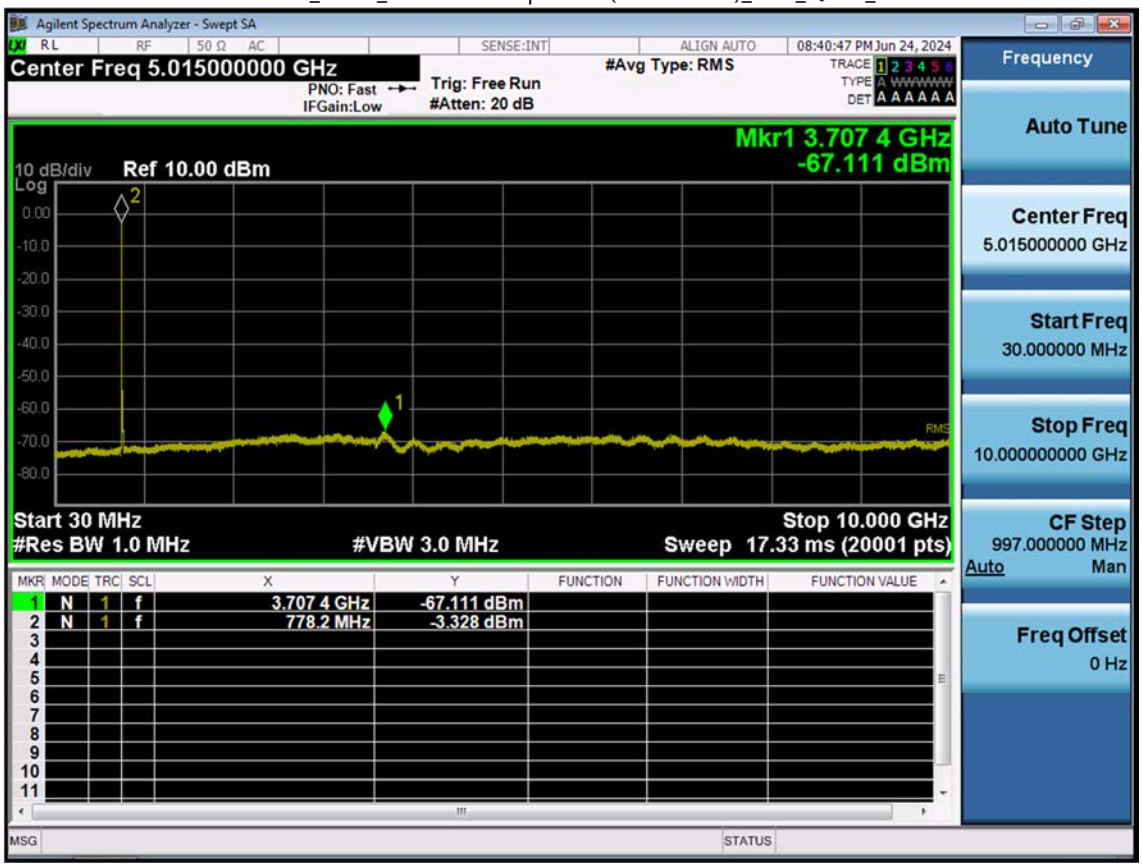
LTE B13_5 M_Conducted Spurious(30 M-10 G)_Mid_QPSK_1RB



LTE B13_5 M_Conducted Spurious(30 M-10 G)_High_QPSK_1RB



LTE B13_10 M_Conducted Spurious(30 M-10 G)_Low_QPSK_1RB



LTE B13_5 M_Band Edge_Low_QPSK_1RB

LTE B13_5 M_Band Edge_Low_QPSK_FullRB

LTE B13_5 M_Extended Band Edge_Low_QPSK_FullRB

LTE B13_5 M_Band Edge_High_QPSK_1RB

LTE B13_5 M_Band Edge_High_QPSK_FullRB

LTE B13_5 M_Extended Band Edge_High_QPSK_FullRB

LTE B13_10 M_Band Edge_Low_QPSK_1RB

LTE B13_10 M_Band Edge_Low_QPSK_FullRB

LTE B13_10 M_Extended Band Edge_Low_QPSK_FullRB

LTE B13_10 M_Band Edge_High_QPSK_1RB

LTE B13_10 M_Band Edge_High_QPSK_FullRB

LTE B13_10 M_Extended Band Edge_High_QPSK_FullRB

10. ANNEX A_ TEST SETUP PHOTO

Please refer to test setup photo file no. as follows;

No.	Description
1	HCT-RF-2407-FC055-P